

**Search Notes**

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Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

IKEDA ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
347	5-13, 37, 39, 73-77	6/20/2005	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
347	11	6/20/2005	HP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/20/2005	HP